

**Search Notes**

Application/Control No.

09/395,207

Examiner

Michael Y. Won

Applicant(s)/Patent under  
Reexamination

AN ET AL.

Art Unit

2155

**SEARCHED**

Class	Subclass	Date	Examiner
709	223	7/15/2002	MW
719	315, 316	1/14/2004	MW
719	317	1/14/2004	MW
707	10, 100	6/15/2004	MW
345	853	6/15/2004	MW
379	230	6/15/2004	MW
713	2	6/15/2004	MW
717	108	6/15/2004	MW
709	202	6/15/2004	MW
719	315, 316	7/14/2005	MW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
719	315, 316	7/20/2005	MW
717	108, 116	7/20/2005	MW
709	203, 223	7/20/2005	MW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	7/15/2002	MW
APPEAL BRIEF CONFERENCE WITH PRIMARY	1/13/2004	MW
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	1/14/2005	MW
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	6/15/2005	MW
DISCUSSED CASE WITH PRIMARY: MAJID BANANKHAH	7/14/2005	MW
DISCUSSED CASE WITH PRIMARY: ST.JOHN COURTENAY III (DIRECTED EXAMINER TO SEARCH 719/315;316	7/14/2005	MW
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	7/14/2005	MW
NPL: IEEE	7/14/2005	MW